Se	arcn	Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/082,211	ONISHI ET AL.	
Examiner	Art Unit	
Karin M. Reichle	3761	

SEARCHED			
Class	Subclass	Date	Examiner
updated		6/15/2005	KMR
·			
		•	
		·	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
		-	
<u> </u>			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
updated Inventor name search in eDAN and EAST search-copies attached	6/15/2005	KMR